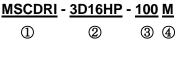
### SCOPE :

This specification applies to the Pb Free high current type SMD inductors for MSCDRI-3D16HP-SERIES

#### **PRODUCT INDENTIFICATION**



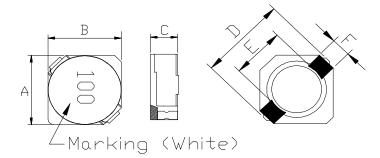
① Product Code

② Dimensions Code

③ Inductance Code

④ Tolerance Code

### (1) SHAPES AND DIMENSIONS



(2) ELECTRICAL	<b>SPECIFICATIONS</b>
SEE TABLE 1	

**TEST INSTRUMENTS** 

L : HP 4284A PRECISION LCR METER (or equivalent)

RDC : CHROMA MODEL 16502 MILLIOHMMETER (or equivalent)

### (3) CHARACTERISTICS

- (3)-1 Ambient temperature ...... +60  $^\circ\!\! C$  Max.
- (3)-2 Operate temperature range ......  $-40^{\circ}$ C  $\sim$   $+125^{\circ}$ C
  - (Including self temp. rise)
- (3)-3 Storage temperature range ......  $-40^{\circ}$ C  $\sim +125^{\circ}$ C

A: 3.80±0.2	mm
B: 3.80±0.2	mm
C: 1.80 Max.	mm
D:∫ 5.40 Max.	mm (1R0~4R7)
<sup>ີ 1</sup> 5.20 Max.	mm (6R8~561)
Е: 2.80 Тур.	mm
F: 1.10 Typ.	mm



### TABLE 1

MAGLAYERS	Inductance	Percent	Test	Resistance	Rated DC Current		Marking
PT/NO.	L(µH)	Tolerance	Frequency	RDC(Ω)Max.	IDC1(A)	IDC2(A)	Marking
MSCDRI-3D16HP-1R0	1.0	N	100kHz/0.25V	48m	2.50	2.80	1R0
MSCDRI-3D16HP-1R2	1.2	N	100kHz/0.25V	49.5m	2.30	2.60	1R2
MSCDRI-3D16HP-1R5	1.5	N	100kHz/0.25V	51m	2.00	2.40	1R5
MSCDRI-3D16HP-1R7	1.7	N	100kHz/0.25V	51m	2.00	2.40	1R7
MSCDRI-3D16HP-2R2	2.2	M,N	100kHz/0.25V	59m	1.75	2.30	2R2
MSCDRI-3D16HP-3R3	3.3	M,N	100kHz/0.25V	85m	1.40	1.80	3R3
MSCDRI-3D16HP-4R7	4.7	M,N	100kHz/0.25V	0.116	1.20	1.50	4R7
MSCDRI-3D16HP-6R8	6.8	M,N	100kHz/0.25V	0.18	1.00	1.10	6R8
MSCDRI-3D16HP-100	10	M,N	100kHz/0.25V	0.23	0.84	1.00	100
MSCDRI-3D16HP-150	15	M,N	100kHz/0.25V	0.41	0.65	0.75	150
MSCDRI-3D16HP-220	22	M,N	100kHz/0.25V	0.61	0.55	0.52	220
MSCDRI-3D16HP-330	33	M,N	100kHz/0.25V	0.87	0.46	0.41	330
MSCDRI-3D16HP-470	47	M,N	100kHz/0.25V	0.95	0.42	0.37	470
MSCDRI-3D16HP-561	560	M,N	100kHz/0.25V	15.0	0.09	0.11	561

**※** □ specify the inductance tolerance,M(±20%),N(±30%)

% IDC1 : Based on inductance change (△L/Lo :  $\leq$  drop 35%)@ ambient temperature 25°C

IDC2 : Based on temperature rise ( $\triangle T$  : 40°C TYP.)

Rated DC Current : The less value which is IDC1 or IDC2.



# (4) RELIABILITY TEST METHOD

# MECHANICAL

TEST ITEM	SPECIFICATION	TEST DETAILS				
Substrate bending	∆L/Lo≦±5%	The sample shall be soldered onto the printed circuit board				
		in figure 1 and a load applied unitil the figure in the arrow				
	There shall be	direction is made approximately 3mm.(keep time 30 seconds)				
	no mechanical	PCB dimension shall the page 7/9				
	damage or elec-	F(Pressurization)				
	trical damege.	л				
		R5 45±2 45±2 10 20 R340				
		PRESSURE ROD figure-1				
Vibration	∆L/Lo≦±5%	The sample shall be soldered onto the printed circuit board				
		and when a vibration having an amplitude of 1.52mm				
	There shall be	and a frequency of from 10 to 55Hz/1 minute repeated should				
	no mechanical	be applied to the 3 directions (X,Y,Z) for 2 hours each.				
	damage.	(A total of 6 hours)				
Solderability	New solder	Flux (rosin, isopropyl alcohol{JIS-K-1522}) shall be coated				
concontraining	More than 90%	over the whole of the sample before hard, the sample shall				
		then be preheated for about 2 minutes in a temperature of				
		130 $\sim$ 150 $^\circ\!\mathbb{C}$ and after it has been immersed to a depth 0.5mm				
		below for $3\pm0.2$ seconds fully in molten solder M705 with				
		a temperature of 245±5℃.				
		More than 90% of the electrode sections shall be couered				
		with new solder smoothly when the sample is taken out of				
		the solder bath.				



#### MECHANICAL

Resistance to There shall be no damage or problems. (reflow soldering) problems. Temperature profile of reflow soldering soldering (Peak temperature 200:3° 10 sec 9 200 250 200 (Peak temperature 200:3° 10 sec 9 200 250 (Peak temperature 200:3° 10 sec 9 200 (Stored at room temperature) The specimen shall be passed through the reflow oven with the condition shown in the above profile for 1 time.	TEST ITEM	SPECIFICATION					
	Resistance to Soldering heat	no damage or	Temperature profile of reflow soldering 300 soldering (Peak temperature 260±3℃ 10 sec 30 sec Mn (230° ℃) 100 file 50 file 50 file 50 file 2 min file 3 m				
The specimen shall be stored at standard atmospheric conditions for 1 hour, after which the measurement shall be made.			condition shown in the above profile for 1 time. The specimen shall be stored at standard atmospheric conditions				

#### ELECTRICAL

TEST ITEM	SPECIFICATION	TEST DETAILS
Insulation	There shall be	DC 100V voltage shall be applied across this sample of top
resistance	no other	surface and the terminal.
	damage or	The insulation resistance shall be more than $1 \times 10^8 \Omega$ .
	problems.	
Dielectric	There shall be	AC 100V voltage shall be applied for 1 minute acrosset the top
withstand	no other	surface and the terminal of this sample
voltage	damage or	
	problems.	
Temperature	∆L/L20℃ ≦±10%	The test shall be performed after the sample has stabilized in
characteristics	0 <b>~2000 ppm/°</b> C	an ambient temperature of -20 to +85 $^\circ\!\!{ m C}$ ,and the value
		calculated based on the value applicable in a normal
		temperature and narmal humidity shall be $\triangle$ L/L20 $\degree$ C $\leq$ ±10%.



# **ENVIROMENT CHARACTERISTICS**

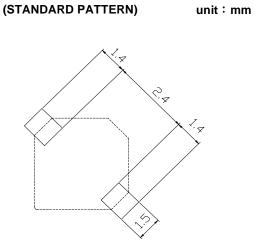
TEST ITEM		SPECIFICATION					
High temperature	∆L/Lo≦±5%	The san	nple s	hall be left for 96±4 hou	rs in an atmospere with	<u></u> ו	
storage		a tempe	a temperature of 85±2 $^\circ\!\!\mathbb{C}$ and a normal humidity.				
	There shall be	Upon co	Upon completion of the measurement shall be made after the				
	no mechanical	sample	has b	een left in a normal tem	perature and normal		
	damage.	humidit	y for 1	hour.			
Low temperature	∆L/Lo≦±5%	The san	nple s	hall be left for 96±4 hou	rs in an atmosphere wi	th	
storage		a tempe	rature	e of -25±3℃.			
	There shall be	Upon co	omple	ion of the test, the mea	surement shall be mad	е	
	no mechanical	after the	e sam	ole has been left in a no	rmal temperature and		
	damage.	normal	humid	ity for 1 hour.			
Change of	∆L/Lo≦±5%	The san	nple s	hall be subject to 5 cont	tinuos cycles, such as s	shown	
temperature		in the ta	ble 2	below and then it shall b	be subjected to standa	rd	
	There shall be	atmosp	atmospheric conditions for 1 hour, after which measurement				
	no other dama-	shall be	shall be made.				
	ge of problems						
			table 2				
				Temperature	Duration		
			1	− <b>25±3°</b> C	30 min.		
				(Themostat No.1)			
			2	Standard	No.1→No.2		
				atmospheric			
			3	<b>85±2℃</b>	30 min.		
				(Themostat No.2)			
			4	Standard	No.2→No.1		
				atmospheric			
Moisture storage	∆L/Lo≦±5%	The sample shall be left for 96±4 hours in a temperature of					
		40±2 $℃$ and a humidity(RH) of 90 $\sim$ 95%.					
	There shall be	Upon completion of the test, the measurement shall be made					
	no mechanical	after the	after the sample has been left in a normal temperature and				
	damage.	normal humidity more than 1 hour.					
Test conditions :		1					
The	sample shall be reflow	w soldered	l onto	the printed circuit boar	d in every test.		



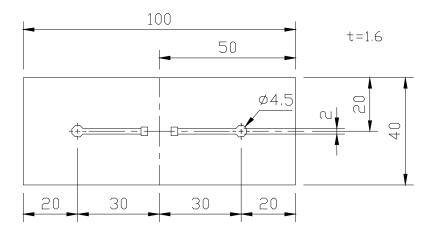


PCB: GLASS EPOXY t=1.6mm

#### (5)-1 LAND PATTERN DIMENSIONS

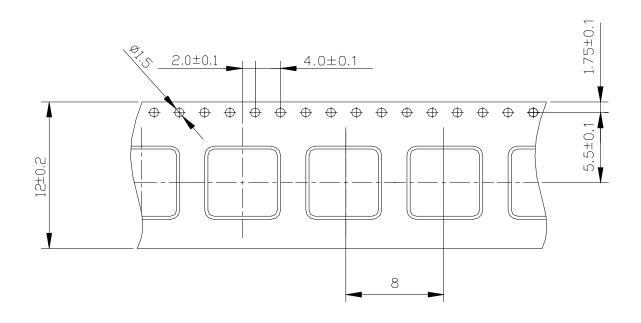


#### (5)-2 SUBSTRATE BENDING TEST BENDING TEST BOARD



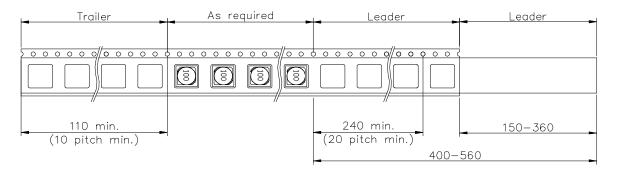


# (6) PACKAGING (6)-1 CARRIER TAPE DIMENSIONS (mm)



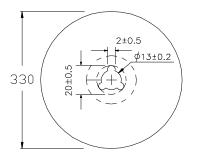
### (6)-2 TAPING DIMENSIONS (mm)

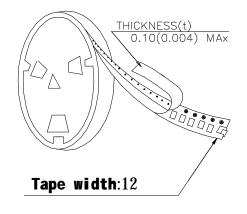






### (6)-3 REEL DIMENSIONS (mm)





#### (6)-4 QUANTITY

3500pcs/Reel

The products are packaged so that no damage will be sustained.

